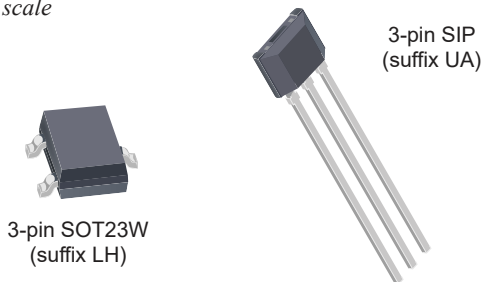# APS13295

Precision Hall-Effect Switch
for Consumer and Industrial Applications

FEATURES AND BENEFITS

- Unipolar switch points
- Superior ruggedness and fault tolerance
- Reverse-polarity and transient protection
- Operation from –40°C to 175°C junction temperature
- Output short-circuit and overvoltage protection
- Superior temperature stability
- Resistant to physical stress
- High EMC immunity, ±12 kV HBM ESD
- Operation from unregulated supplies, 2.8 to 24 V
- Chopper stabilization
- Solid-state reliability
- Industry-standard packages and pinouts

PACKAGES:

Not to scale

3-pin SIP
(suffix UA)

3-pin SOT23W
(suffix LH)

DESCRIPTION

The APS13295 Hall-effect switch is a three-wire, planar Hall-effect sensor integrated circuit (IC) especially suited for operation over extended temperature ranges (up to 125°C).

This Hall-effect switch IC is ideal for industrial and consumer applications and features performance enhancements permitting high-temperature operation up to 175°C junction temperatures. In addition, the APS13295 includes a number of features designed specifically to maximize system robustness such as reverse-polarity protection, output current limiter, overvoltage, and EMC protection.

The single silicon chip includes: a voltage regulator, a Hall plate, small signal amplifier, chopper stabilization, Schmitt trigger, and a short-circuit-protected open-drain output. A south pole of sufficient strength turns the output on. Removal of the magnetic field—or a north pole—turns the output off. The devices include on-board transient protection for all pins, permitting operation directly from unregulated or regulated supplies from 2.8 to 24 V.

Two package styles provide a choice of through-hole or surface mounting. Package type LH is a modified SOT23W, surface-mount package, while UA is a three-lead ultra-mini SIP for through-hole mounting. Both packages are lead (Pb) free and RoHs compliant with 100% matte-tin leadframe plating.

Functional Block Diagram
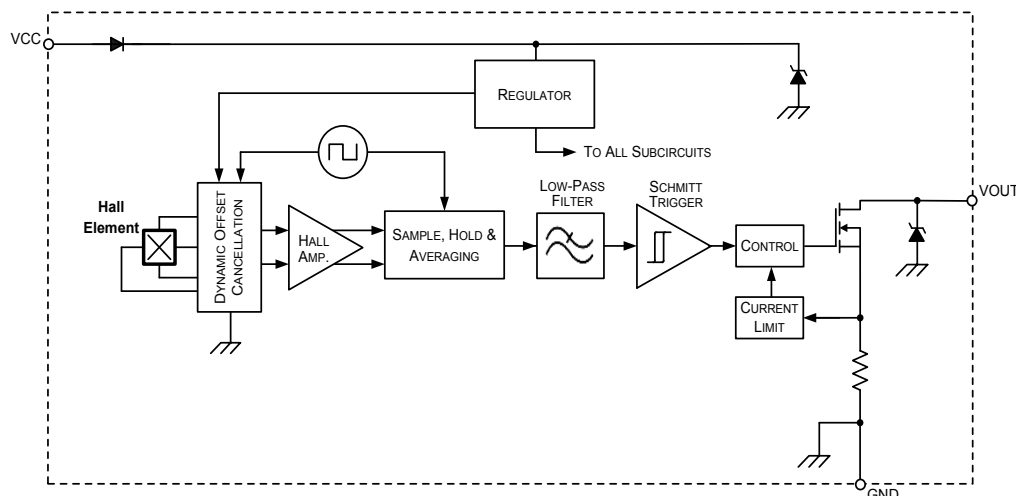
SELECTION GUIDE

Part Number	Packing [1]	Mounting	Branding	Ambient Temperature, T_A	Switch Points (Typ.)	
					B_{OP}	B_{RP}
APS13295KLHALX	13-in. reel, 10000 pieces/reel	3-pin SOT23W surface mount	A33			
APS13295KLHALT[2]	7-in. reel, 3000 pieces/reel	3-pin SOT23W surface mount	A33	–40°C to 125°C	35 G	25 G
APS13295KUAA	Bulk, 500 pieces/bag	3-pin SIP through hole	A34			

[1] Contact Allegro for additional packing options.
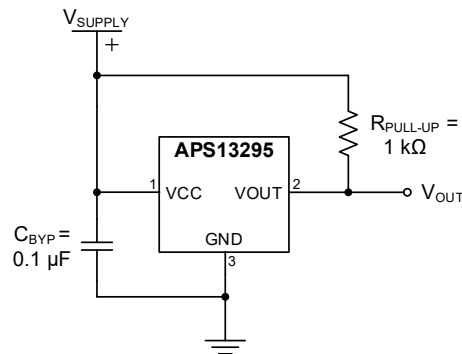[2] Available through authorized Allegro distributors only.

Figure 1: Typical Application Circuit

APS13295

## Precision Hall-Effect Switch for Consumer and Industrial Applications

ABSOLUTE MAXIMUM RATINGS

Characteristic	Symbol	Notes	Rating	Units
Forward Supply Voltage [1]	V_{CC}		30	V
Reverse Supply Voltage [1]	V_{RCC}		−18	V
Output Off Voltage [1]	V_{OUT}		30	V
Output Current [2]	I_{OUT}		60	mA
Reverse Output Current	I_{ROUT}		−50	mA
Magnetic Flux Density [3]	B		Unlimited	−
Maximum Junction Temperature	$T_J(max)$		165	°C
		For 500 hours	175	°C
Storage Temperature	T_{stg}		−65 to 170	°C
ESD Voltage	$V_{ESD(HBM)}$	Human Body Model according to AEC-Q100-002	±12	kV
	$V_{ESD(CDM)}$	Charged Device Model according to AEC-Q100-011	±1	kV

[1] This rating does not apply to extremely short voltage transients such as load dump and/or ESD. Those events have individual ratings, specific to the respective transient voltage event.
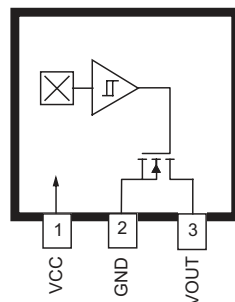
[2] Through short-circuit current limiting device.

[3] Guaranteed by design.

PINOUT DIAGRAMS AND TERMINAL LIST
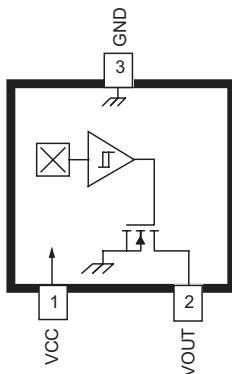
3-pin SOT23W
(suffix LH)

3-pin SIP
(suffix UA)

Terminal List

Name	Description	Number	
		LH	UA
VCC	Connects power supply to chip	1	1
VOUT	Output from circuit	2	3
GND	Ground	3	2

Precision Hall-Effect Switch
for Consumer and Industrial Applications

ELECTRICAL CHARACTERISTICS: Valid over full operating voltage, ambient temperature range T_A = –40°C to 125°C, and with C_{BYP} = 0.1 µF, unless otherwise specified

Characteristics	Symbol	Test Conditions	Min.	Typ.[1]	Max.	Unit [2]
ELECTRICAL CHARACTERISTICS						
Forward Supply Voltage	V_{CC}	Operating, T_J < 175°C	2.8	–	24	V
Supply Current	I_{CC}		1	2	3	mA
Output Leakage Current	I_{OUTOFF}	V_{OUTOFF} = 24 V, B < B_{RP}	–	–	10	µA
Output Saturation Voltage	$V_{OUT(SAT)}$	I_{OUT} = 20 mA, B > B_{OP}	–	200	500	mV
Output Off Voltage	V_{OUTOFF}	B < B_{RP}	–	–	24	V
Power-On Time [3]	t_{ON}	V_{CC} ≥ V_{CC}(min), B < B_{RP}(min) – 10 G, B > B_{OP}(max) + 10 G	–	–	25	µs
Power-On State, Output [3]	POS	V_{CC} ≥ V_{CC}(min), t < t_{ON}		Low		–
Chopping Frequency	f_C		–	800	–	kHz
Output Rise Time [4]	t_r	$R_{PULL-UP}$ = 1 kΩ, C_L = 20 pF	–	0.2	2	µs
Output Fall Time [4]	t_f	$R_{PULL-UP}$ = 1 kΩ, C_L = 20 pF	–	0.1	2	µs
TRANSIENT PROTECTION CHARACTERISTICS						
Output Short-Circuit Current Limit	I_{OM}		30	–	60	mA
Output Zener Clamp Voltage	$V_{Zoutput}$	I_{OUTOFF} = 3 mA; T_A = 25°C, Output Off	30	–	–	V
Reverse Battery Current	I_{RCC}	V_{RCC} = –18 V, T_A = 25°C	–	–	–5	mA
Supply Zener Clamp Voltage	V_Z	I_{CC} = I_{CC}(max) + 3 mA, T_A = 25°C	30	–	–	V
MAGNETIC CHARACTERISTICS						
Operate Point	B_{OP}		–	35	50	G
Release Point	B_{RP}		5	25	–	G
Hysteresis	B_{HYS}	(B_{OP} – B_{RP})	7	10	20	G

[1] Typical data are at T_A = 25°C and V_{CC} = 12 V.
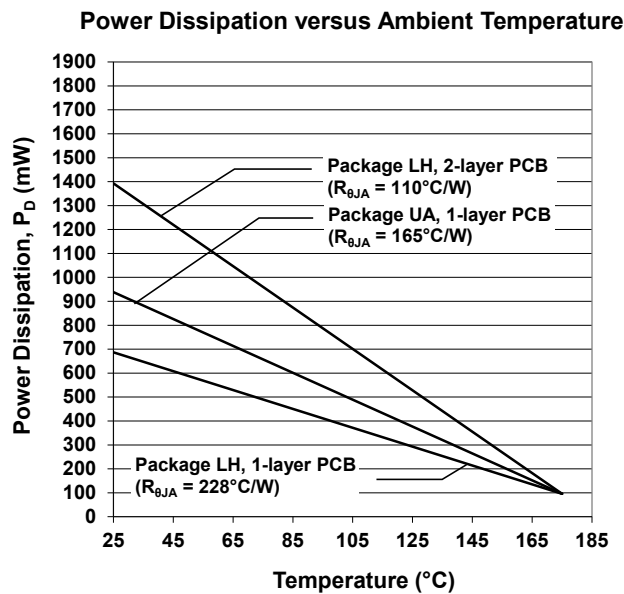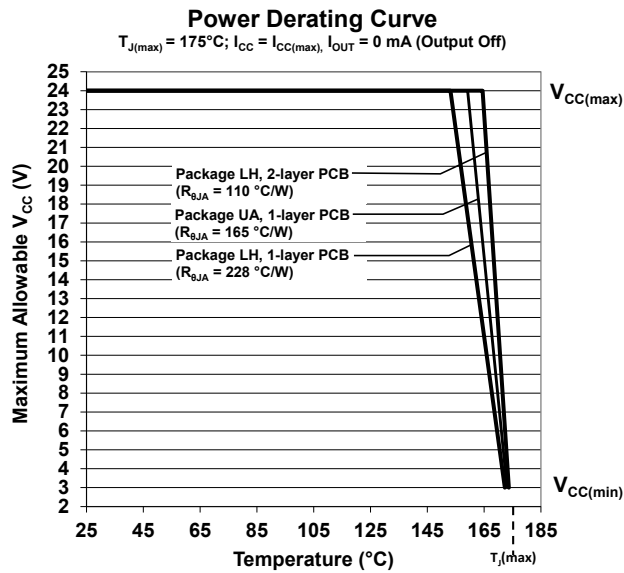[2] 1 G (gauss) = 0.1 mT (millitesla).
[3] Guaranteed by device design and characterization.
[4] C_L = oscilloscope probe capacitance.

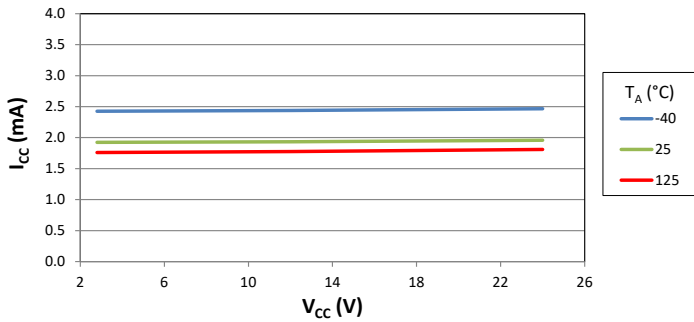**THERMAL CHARACTERISTICS: May require derating at maximum conditions; see application information**

Characteristic	Symbol	Test Conditions	Value	Units
Package Thermal Resistance	$R_{\theta JA}$	Package LH, 1-layer PCB with copper limited to solder pads	228	°C/W
		Package LH, 2-layer PCB with 0.463 in^2 of copper area each side connected by thermal vias	110	°C/W
		Package UA, 1-layer PCB with copper limited to solder pads	165	°C/W

Power Derating Curve

$T_{J(max)}$ = 175°C; I_{CC} = $I_{CC(max)}$, I_{OUT} = 0 mA (Output Off)

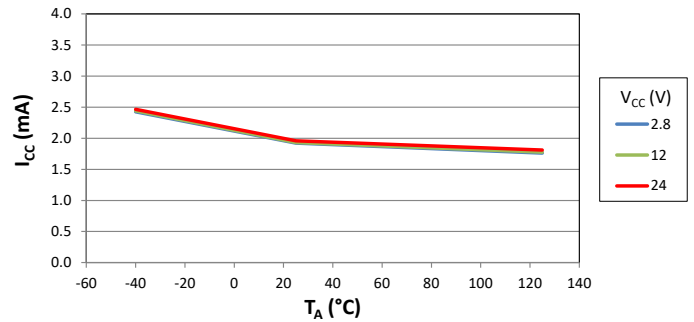**Power Dissipation versus Ambient Temperature**
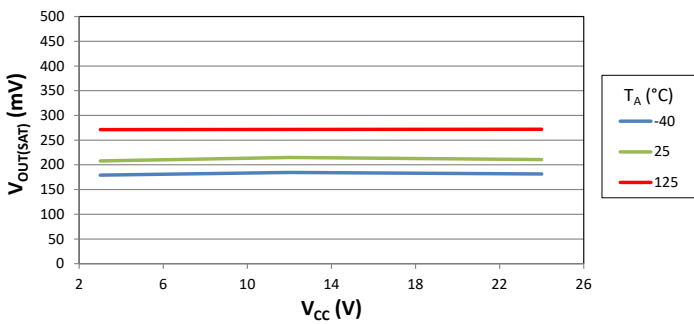
CHARACTERISTIC PERFORMANCE DATA
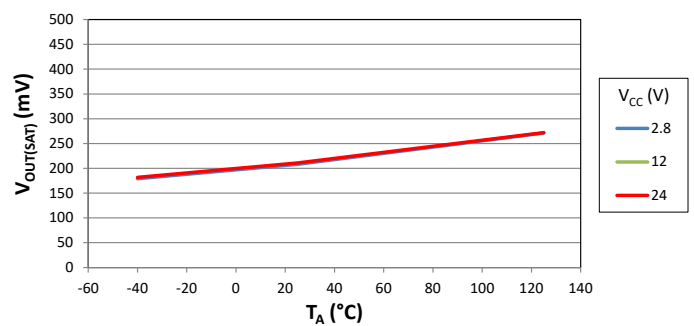

Average Supply Current versus Supply Voltage


Average Supply Current versus Ambient Temperature

Average Low Output Voltage versus Supply Voltage for I_{OUT} = 20 mA

Average Low Output Voltage versus Ambient Temperature for I_{OUT} = 20 mA

CHARACTERISTIC PERFORMANCE DATA (continued)

Average Operate Point versus Supply Voltage

Average Operate Point versus Ambient Temperature

Average Release Point versus Supply Voltage

Average Release Point versus Ambient Temperature

Average Switchpoint Hysteresis versus Supply Voltage

Average Switchpoint Hysteresis versus Ambient Temperature
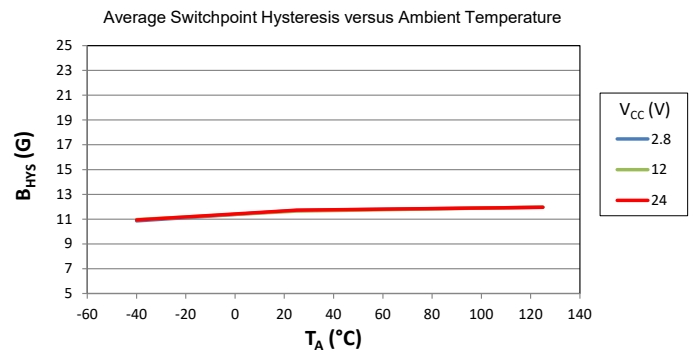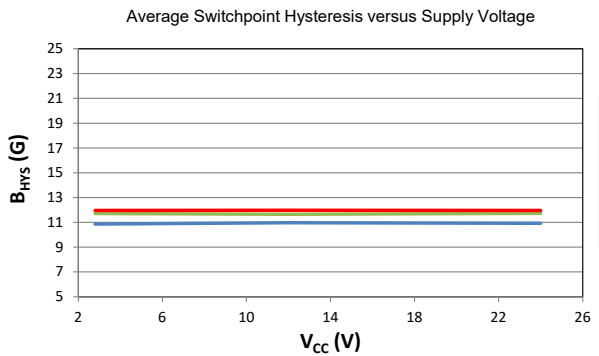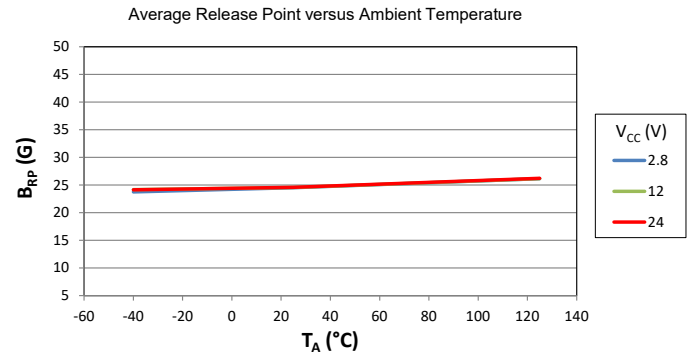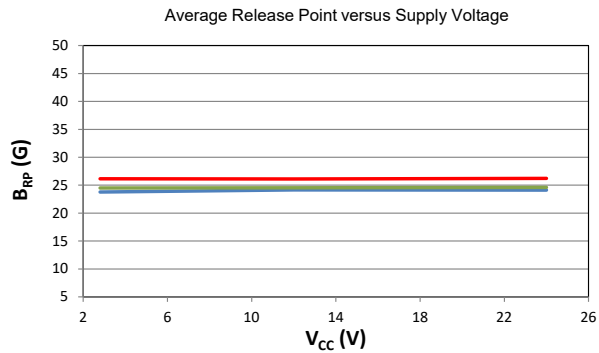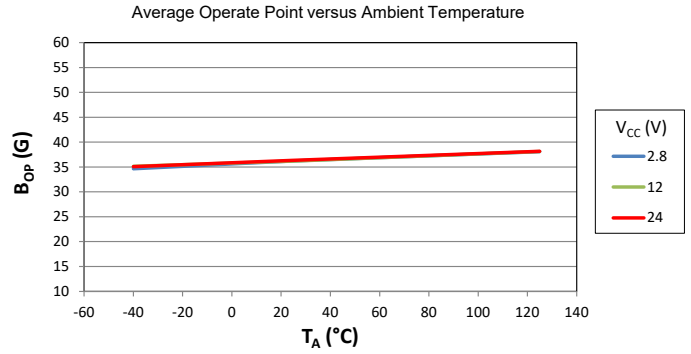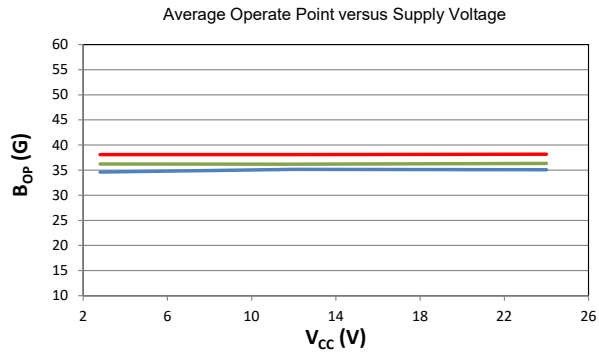
FUNCTIONAL DESCRIPTION

OPERATION

The output of the APS13295 switches low (turns on) when a south-polarity magnetic field perpendicular to the Hall element exceeds the operate point threshold, B_{OP} (see Figure 2). After turn-on, the output voltage is $V_{OUT(SAT)}$. The output transistor is capable of continuously sinking up to 30 mA. When the magnetic field is reduced below the release point, B_{RP}, the device output goes high (turns off) to V_{OUTOFF}.
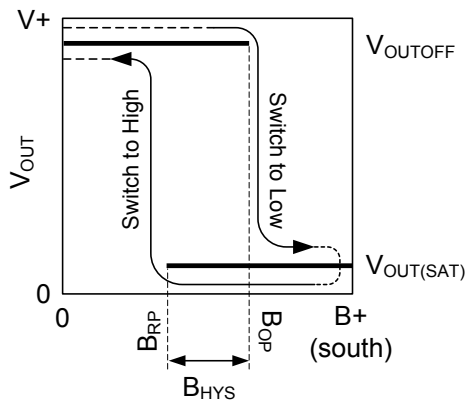

Figure 2: Device Switching Behavior

On the horizontal axis, the B+ direction indicates increasing south polarity magnetic field strength.

The difference in the magnetic operate and release points is the hysteresis, B_{HYS}, of the device. This built-in hysteresis allows clean switching of the output even in the presence of external mechanical vibration and electrical noise.

POWER-ON BEHAVIOR

Device power-on occurs once t_{ON} has elapsed. During the time prior to t_{ON}, and after $V_{CC} \geq V_{CC}(min)$, the output state is $V_{OUT(SAT)}$. After t_{ON} has elapsed, the output will correspond with the applied magnetic field for $B > B_{OP}$ or $B < B_{RP}$. See Figure 3 for an example.

Powering-on the device in the hysteresis range (less than B_{OP} and higher than B_{RP}) will give an output state of V_{OUTOFF}. The correct state is attained after the first excursion beyond B_{OP} or B_{RP}.
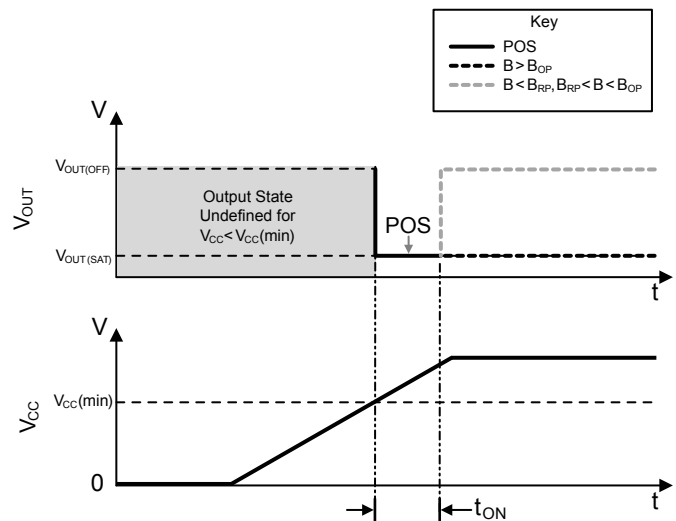

Figure 3: Power-On Sequence and Timing

Applications

It is strongly recommended that an external bypass capacitor be connected (in close proximity to the Hall element) between the supply and ground of the device to guarantee correct performance under harsh environmental conditions and to reduce noise from internal circuitry. As is shown in Figure 1: Typical Application Circuit, a 0.1 µF capacitor is required. In applications where maximum robustness is required, additional measures may be taken. In Figure 4: Enhanced Protection Circuit, a resistor in series with the VCC pin and a capacitor on the VOUT pin enhance the EMC immunity of the device. It is up to the user to fully qualify the Allegro sensor IC in their end system to ensure they achieve their system requirements.

These devices are sensitive in the direction perpendicular to the branded package face, and may be configured to sense magnetic fields in a variety of orientations, such as the ones shown in Figure 5.

Extensive applications information for Hall-effect devices is available in:

*   *Hall-Effect IC Applications Guide, AN27701,*
*   *Hall-Effect Devices: Guidelines for Designing Subassemblies Using Hall-Effect Devices AN27703.1*
*   *Soldering Methods for Allegro's Products – SMD and Through-Hole, AN26009*

All are provided on the Allegro website:

www.allegromicro.com
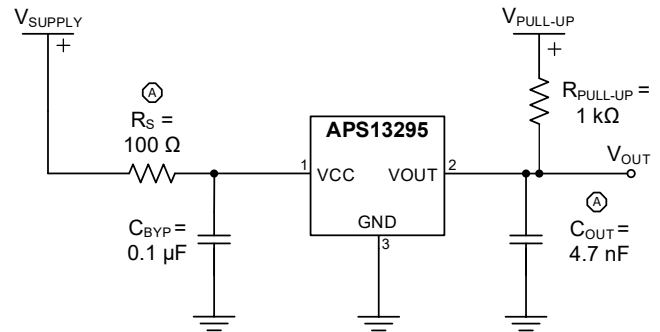
Ⓐ R_S and C_{OUT} are recommended for maximum robustness in an automotive environment.

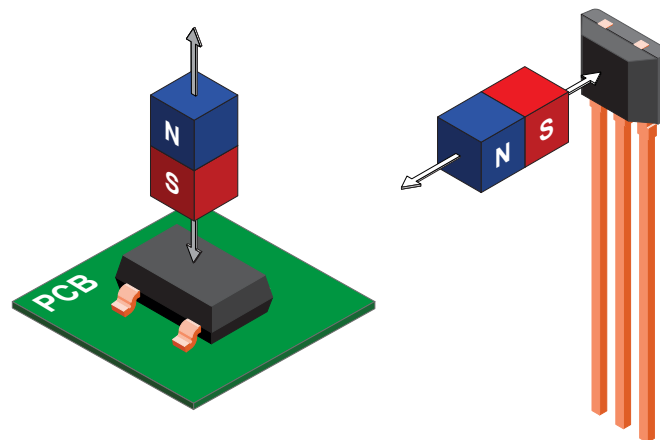**Figure 4: Enhanced Protection Circuit**


Figure 5: Sensing Configurations

CHOPPER STABILIZATION

A limiting factor for switch point accuracy when using Hall-effect technology is the small-signal voltage developed across the Hall plate. This voltage is proportionally small relative to the offset that can be produced at the output of the Hall sensor. This makes it difficult to process the signal and maintain an accurate, reliable output over the specified temperature and voltage range. Chopper stabilization is a proven approach used to minimize Hall offset.

The Allegro technique, dynamic quadrature offset cancellation, removes key sources of the output drift induced by temperature and package stress. This offset reduction technique is based on a signal modulation-demodulation process. Figure 6: Model of Chopper Stabilization Circuit (Dynamic Offset Cancellation) illustrates how it is implemented.

The undesired offset signal is separated from the magnetically induced signal in the frequency domain through modulation.

The subsequent demodulation acts as a modulation process for the offset causing the magnetically induced signal to recover its original spectrum at baseband while the DC offset becomes a high-frequency signal. Then, using a low-pass filter, the signal passes while the modulated DC offset is suppressed. Allegro's innovative chopper stabilization technique uses a high-frequency clock. The high-frequency operation allows a greater sampling rate that produces higher accuracy, reduced jitter, and faster signal processing. Additionally, filtering is more effective and results in a lower noise analog signal at the sensor output. Devices such as the APS13295 that use this approach have an extremely stable quiescent Hall output voltage, are immune to thermal stress, and have precise recoverability after temperature cycling. This technique is made possible through the use of a BiCMOS process which allows the use of low-offset and low-noise amplifiers in combination with high-density logic and sample-and-hold circuits.
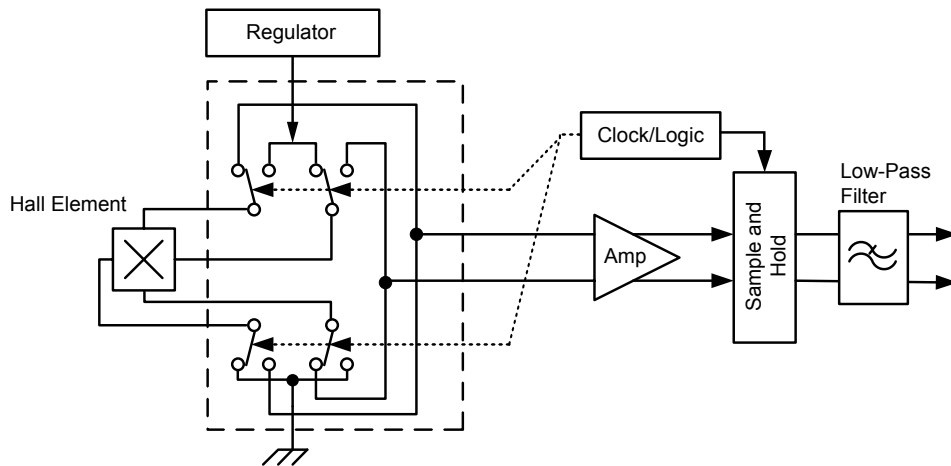
**Figure 6: Model of Chopper Stabilization Circuit
(Dynamic Offset Cancellation)**

POWER DERATING

The device must be operated below the maximum junction temperature of the device, T_J(max). Under certain combinations of peak conditions, reliable operation may require derating supplied power or improving the heat dissipation properties of the application. This section presents a procedure for correlating factors affecting operating T_J. (Thermal data is also available on the Allegro MicroSystems website.)

The Package Thermal Resistance, $R_{\theta JA}$, is a figure of merit summarizing the ability of the application and the device to dissipate heat from the junction (die), through all paths to the ambient air. Its primary component is the Effective Thermal Conductivity, K, of the printed circuit board, including adjacent devices and traces. Radiation from the die through the device case, $R_{\theta JC}$, is relatively small component of $R_{\theta JA}$. Ambient air temperature, T_A, and air motion are significant external factors, damped by overmolding.

The resulting power dissipation capability directly reflects upon the ability of the device to withstand extreme operating conditions. The junction temperature mission profile specified in the Absolute Maximum Ratings table designates a total operating life capability based on qualification for the most extreme conditions, where T_J may reach 175°C.

The silicon IC is heated internally when current is flowing into the VCC terminal. When the output is on, current sinking into the VOUT terminal generates additional heat. This may increase the junction temperature, T_J, above the surrounding ambient temperature. The APS13295 is permitted to operate up to T_J = 175°C. As mentioned above, an operating device will increase T_J according to equations 1, 2, and 3 below. This allows an estimation of the maximum ambient operating temperature.

$$P_D = V_{IN} \times I_{IN} \qquad (1)$$
$$\Delta T = P_D \times R_{\theta JA} \qquad (2)$$
$$T_J = T_A + \Delta T \qquad (3)$$

For example, given common conditions such as: T_A = 25°C, V_{CC} = 12 V, I_{CC} = 2 mA, V_{OUT} = 185 mV, I_{OUT} = 20 mA (output on), and $R_{\theta JA}$ = 165°C/W, then:

$$P_D = (V_{CC} \times I_{CC}) + (V_{OUT} \times I_{OUT}) =$$
$$(12\ V \times 2\ mA) + (185\ mV \times 20\ mA) =$$
$$24\ mW + 3.7\ mW = 27.7\ mW$$

$$\Delta T = P_D \times R_{\theta JA} = 27.7\ mW \times 165°C/W = 4.6°C$$

$$T_J = T_A + \Delta T = 25°C + 4.6°C = 29.6°C$$

A worst-case estimate, P_D(max), represents the maximum allowable power level (V_{CC}(max), I_{CC}(max)), without exceeding T_J(max), at a selected $R_{\theta JA}$.

For example, given the conditions $R_{\theta JA}$ = 228°C/W, T_J(max) = 175°C, V_{CC}(max) = 24 V, I_{CC}(max) = 4 mA, V_{OUT} = 500 mV, and I_{OUT} = 25 mA (output on), the maximum allowable operating ambient temperature can be determined.

The power dissipation required for the output is shown below:

$$P_D(V_{OUT}) = V_{OUT} \times I_{OUT} = 500\ mV \times 25\ mA = 12.5\ mW$$

The power dissipation required for the IC supply is shown below:

$$P_D(V_{CC}) = V_{CC} \times I_{CC} = 24\ V \times 4\ mA = 96\ mW$$

Next, by inverting using equation 2:

$$\Delta T = P_D \times R_{\theta JA} = [P_D(V_{OUT}) + P_D(V_{CC})] \times 228°C/W =$$
$$(12.5\ mW + 96\ mW) \times 228°C/W =$$
$$108.5\ mW \times 228°C/W = 24.7°C$$

Finally, by inverting equation 3 with respect to voltage:

$$T_A(est) = T_J(max) – \Delta T = 175°C – 24.7°C = 150.3°C$$

In the above case, there is sufficient power dissipation capability to operate up to T_A(est).The example indicates that T_A(max) can be as high as 150.3°C without exceeding T_J(max). However, the T_A(max) rating of the device is 125°C; the APS13295 performance is not guaranteed above T_A = 125°C.
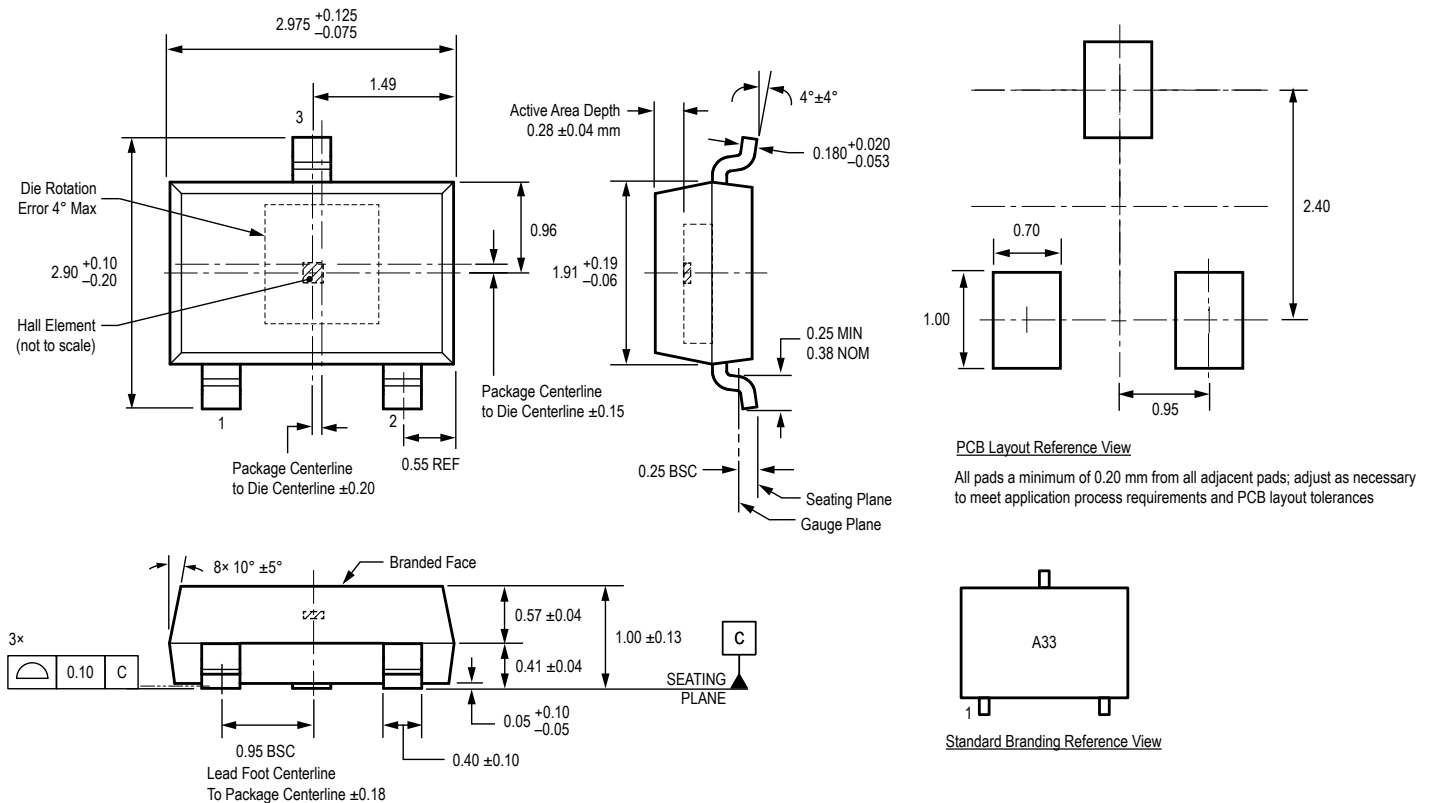
Package LH, 3-Pin (SOT-23W)

For Reference Only – Not for Tooling Use

(Reference Allegro DWG-0000628, Rev. 1)
NOT TO SCALE
Dimensions in millimeters
Dimensions exclusive of mold flash, gate burrs, and dambar protrusions
Exact case and lead configuration at supplier discretion within limits shown

$2.975 \, ^{+0.125}_{-0.075}$

1.49

3

Die Rotation Error 4° Max

$2.90 \, ^{+0.10}_{-0.20}$

Hall Element (not to scale)

0.96

1

2

Package Centerline to Die Centerline ±0.20

0.55 REF

Package Centerline to Die Centerline ±0.15

Active Area Depth 0.28 ±0.04 mm

4°±4°

$0.180 \, ^{+0.020}_{-0.053}$

$1.91 \, ^{+0.19}_{-0.06}$

0.25 MIN
0.38 NOM

0.25 BSC

Seating Plane
Gauge Plane

2.40

0.70

1.00

0.95

PCB Layout Reference View

All pads a minimum of 0.20 mm from all adjacent pads; adjust as necessary to meet application process requirements and PCB layout tolerances

8× 10° ±5°

Branded Face

3×

0.10 | C

0.57 ±0.04

0.41 ±0.04

1.00 ±0.13

C

SEATING PLANE

$0.05 \, ^{+0.10}_{-0.05}$

0.95 BSC
Lead Foot Centerline To Package Centerline ±0.18

0.40 ±0.10

A33

1

Standard Branding Reference View

ALLEGRO microsystems

APS13295

Precision Hall-Effect Switch
for Consumer and Industrial Applications
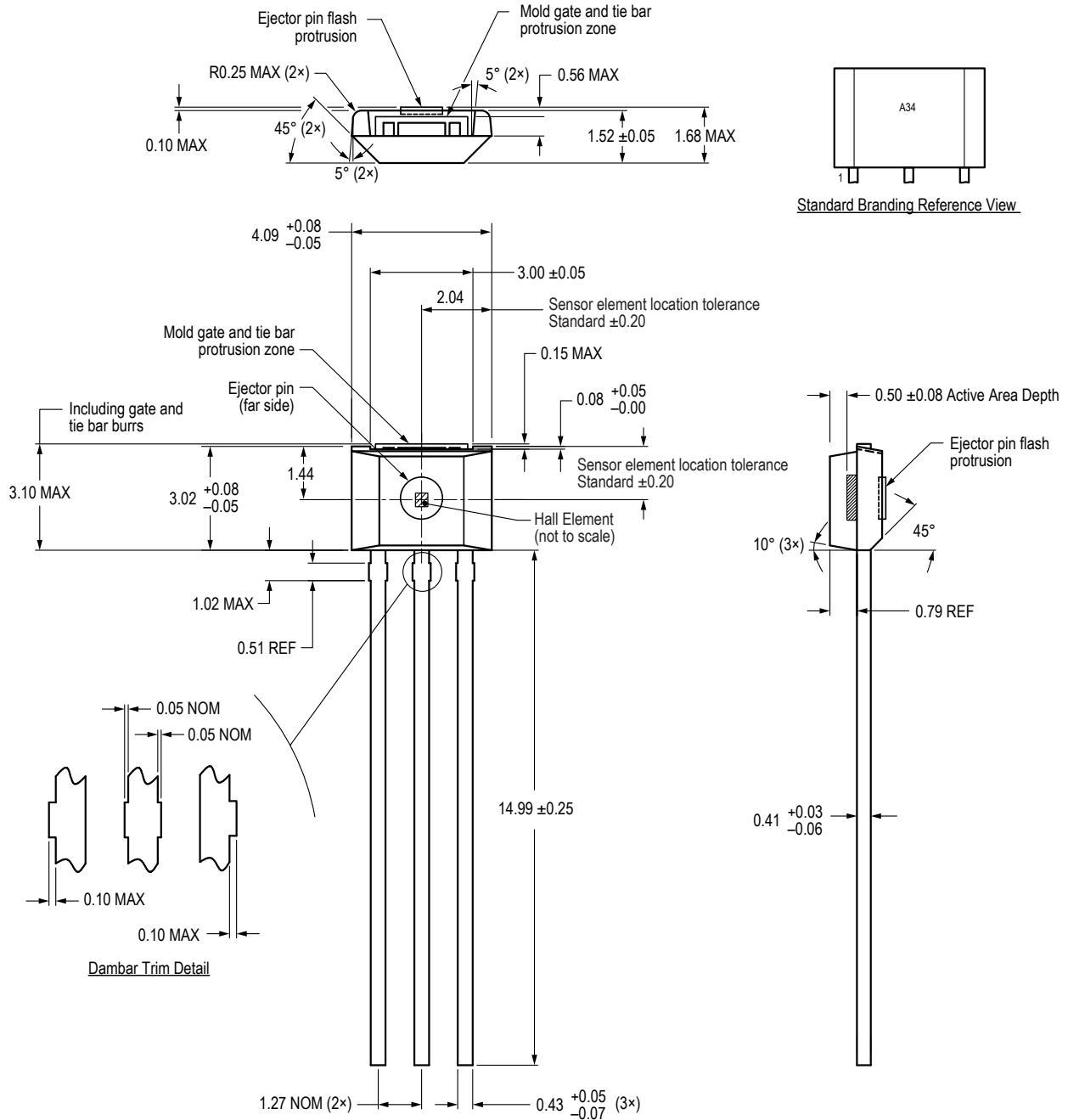
Package UA, 3-Pin SIP

For Reference Only – Not For Tooling Use
(Reference DWG-0000404, Rev. 1)
NOT TO SCALE
Dimensions in millimeters
Exact case and lead configuration at supplier discretion within limits shown

Ejector pin flash protrusion

Mold gate and tie bar protrusion zone

R0.25 MAX (2×)

5° (2×)   0.56 MAX

45° (2×)

0.10 MAX

5° (2×)

1.52 ±0.05   1.68 MAX

A34

1

Standard Branding Reference View

4.09 $^{+0.08}_{-0.05}$

3.00 ±0.05

2.04

Sensor element location tolerance
Standard ±0.20

0.15 MAX

Mold gate and tie bar protrusion zone

Ejector pin (far side)

0.08 $^{+0.05}_{-0.00}$

Including gate and tie bar burrs

0.50 ±0.08 Active Area Depth

Ejector pin flash protrusion

3.10 MAX

3.02 $^{+0.08}_{-0.05}$

1.44

Sensor element location tolerance
Standard ±0.20

Hall Element (not to scale)

10° (3×)

45°

1.02 MAX

0.51 REF

0.79 REF

0.05 NOM

0.05 NOM

14.99 ±0.25

0.41 $^{+0.03}_{-0.06}$

0.10 MAX

0.10 MAX

Dambar Trim Detail

1.27 NOM (2×)

0.43 $^{+0.05}_{-0.07}$ (3×)

Precision Hall-Effect Switch
for Consumer and Industrial Applications

Revision History

Number	Date	Description
–	February 26, 2018	Initial release
1	May 10, 2018	Corrected part numbers in selection guide (page 2); renamed R_{LOAD} to $R_{PULL-UP}$ (page 2, 4, 9).
2	August 2, 2019	Minor editorial updates
3	October 4, 2021	Updated package drawings (pages 12-13)

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www.allegromicro.com